Notice of References Cited	Application/Control No. 10/594,482	Applicant(s)/Patent Under Reexamination LABITZKE ET AL.	
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	HIEU T. VO	3747	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,384,551 B1	05-2002	Watanabe, Hirofumi	318/139
*	В	US-7,098,628 B2	08-2006	Maehara et al.	322/28
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	х			

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